

## **U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A01						
	A02						
	A03						
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSL *Abstrac	
							YES	NO
{V/	B01	JP6-87874	12/22/1994	Japan			X	
V/	B02	JP8-111438	4/30/1996	Japan			*X	
V/	B03	JP2002-107408	4/10/2002	Japan			*X	
	B04							
	B05							

	EXAMINER	/Roberto Velez/	DATE CONSIDERED	. 07/17/2008
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.